

Notice of References Cited	Application/Control No. 10/500,624		Applicant(s)/Patent Under Reexamination MIYAZAKI ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0207280	10-2004	Luo et al.	310/156.47
*	B	US-2004/0217665	11-2004	Hans, Helmut	310/156.47
*	C	US-6,952,064	10-2005	Hiwaki et al.	310/214
*	D	US-2003/0011272	01-2003	Kataoka et al.	310/254
*	E	US-6,252,323	06-2001	Nishikawa et al.	310/156.01
*	F	US-6,369,686	04-2002	Pielok, Gerhard	336/234
*	G	US-4,616,151	10-1986	Pryjmak, Bohdan I.	310/216
*	H	US-2003/0230947	12-2003	Islam et al.	310/156.47
*	I	US-2004/0164635	08-2004	Takahashi et al.	310/156.47
*	J	US-2004/0021392	02-2004	LaBrush, Edward Clarence	310/216
*	K	US-2004/0124728	07-2004	Yamaguchi et al.	310/156.25
*	L	US-2005/0023919	02-2005	Nakano et al.	310/156.47
*	M	US-5,220,228	06-1993	Sibata, Yutaka	310/254

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 9840952 A1	09-1998	World Intellect	KAWANO et al.	H02K 01/22
*	O	EP 1052761 A2	11-2000	European Patent	KINOSHITA, YUKIO	H02K 21/14
*	P	JP 2001037113 A	02-2001	Japan	KAWADA et al.	H02K 01/18
	Q	JP 2002136003 A	10-2002	Japan	DAIKOKU et al.	H02K 01/18
*	R	JP 2005261188 A	09-2005	Japan	KANEKAWA et. al.	H02K001/02
*	S	JP 2004159492 A	06-2004	Japan	YAMAGUCHI et. al	H02K001/27
*	T	JP 2003032939 A	01-2003	Japan	HIWAKI et. al.	H02K003/52

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,086,245	02-1992	Sieja et al.	310/216
*	B	US-2002/0047431	04-2002	Fukushima, Tetsuharu	310/156.47
*	C	US-2005/0121990	06-2005	Kaneko, Yutaro	310/156.47
*	D	US-6,414,413	07-2002	Arai et al.	310/214
*	E	US-5,397,951	03-1995	Uchida et al.	310/156.21
*	F	US-6,876,115	04-2005	Takahashi et al.	310/156.47
*	G	US-7,067,948	06-2006	Yamaguchi et al.	310/156.47
*	H	US-5,969,454	10-1999	Pengov et al.	310/162
*	I	US-6,867,524	03-2005	Liang, Feng	310/156.47
*	J	US-5,861,699	01-1999	Kopac, Ljubomir	310/254
*	K	US-6,597,078	07-2003	Crapo et al.	310/156.01
*	L	US-6,707,209	03-2004	Crapo et al.	310/156.43
*	M	US-6,657,349	12-2003	Fukushima, Tetsuharu	310/156.47

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 2003284276 A1	10-2003	Japan	YAMAGUCHI et. al.	H02K001/27
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	W	
	X	

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,489,249	12-1984	Olivier, Michel	310/216
*	B	US-4,761,576	08-1988	Savage, Jack W.	310/51
*	C	US-6,777,847	08-2004	Saban et al.	310/211
*	D	US-6,873,081	03-2005	Arai et al.	310/215
*	E	US-6,906,443	06-2005	Luo et al.	310/156.47
*	F	US-2006/0244335	11-2006	Miyazaki et al.	310/216
*	G	US-5,010,266	04-1991	Uchida, Hiroyuki	310/156.22
*	H	US-2006/0192456	08-2006	Yamaguchi et al.	310/156.47
*	I	US-2004/0195926	10-2004	Hiwaki et al.	310/216
*	J	US-2002/0067092	06-2002	Crapo et al.	310/156.47
*	K	US-2002/0130580	09-2002	Arai et al.	310/214
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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